

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/623,286 FINN ET AL.	
		Examiner	Art Unit	Page 1 of 1 Devona E. Faulk 2615

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0158460	08-2004	Finn et al.	704/205
*	C	US-6,252,969	06-2001	Ando, Shigeo	381/103
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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